

Notice of References Cited	Application/Control No. 10/035,175	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner DuyVu n Deo	Art Unit 1765

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	C	US-5,811,347	09-1998	Gardner et al.	438/435
	D	US-5,372,950	12-1994	Kim et al.	437/24
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NON-PATENT DOCUMENTS

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	U	Claims of application 10/270,348
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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